



POWER FIELD EFFECT TRANSISTOR

GENERAL DESCRIPTION

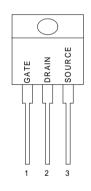
This high voltage MOSFET uses an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition, this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

FEATURES

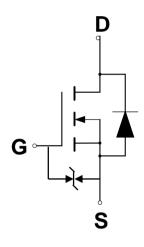
- Robust High Voltage Termination
- ◆ Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits
- ◆ I_{DSS} and V_{DS}(on) Specified at Elevated Temperature

PIN CONFIGURATION





SYMBOL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS

Rating		Value	Unit
Drain to Current — Continuous	I _D	8.5	Α
Pulsed	I _{DM}	25.5	
Gate-to-Source Voltage — Continue	V_{GS}	±30	V
Total Power Dissipation (TO220)	P _D	140	W
(TO220F)		42	W/°C
Derate above 25℃ (TO220)		1	
(TO220F)		0.32	
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to 150	$^{\circ}\!\mathbb{C}$
Single Pulse Drain-to-Source Avalanche Energy $-$ T _J = 25° C	E _{AS}	245	mJ
$(V_{DD} = 100V, V_{GS} = 10V, I_{L} = 7A, L = 10mH, R_{G} = 25)$			
Thermal Resistance — Junction to Case (TO220)	JC	0.92	°CW
(TO220F)		4	
 Junction to Ambient 	JA	62.5	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	$^{\circ}\mathbb{C}$
ESD SENSITIVITY - HBM, C=100pF, R=1.5k	Vesd	2000	V



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ORDERING INFORMATION

Part Number	Package
GPT09N50DGN220FP*	TO-220F
GPT09N50GN220FP*	TO-220F
GPT09N50GN220*	TO-220

*Note: G: Suffix for PB Free Product

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $T_J = 25^{\circ}C$.

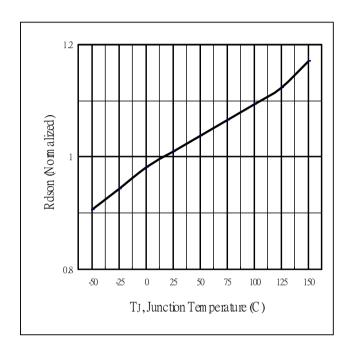
				GPT09N50		
Characteristic		Symbol	Min	Тур	Max	Units
Drain-Source Breakdown Voltage		V _{(BR)DSS}	500			V
$(V_{GS} = 0 \text{ V}, I_D = 250 \ \mu \text{ A})$						
Drain-Source Leakage Current		I _{DSS}			1	μA
$(V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V})$						
Gate-Source Leakage Current-Forward		I_{GSSF}			100	nA
$(V_{gsf} = 30 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate-Source Leakage Current-Ro	Gate-Source Leakage Current-Reverse				100	nA
$(V_{gsr} = -30 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate Threshold Voltage		$V_{GS(th)}$	3		5	V
$(V_{DS} = V_{GS}, I_D = 250 \mu A)$						
Static Drain-Source On-Resistance (V _{GS} = 10 V, I _D = 4.5A) *		R _{DS(on)}			0.8	
Forward Transconductance (V _{DS}	= 50 V, I _D = 4.5A) *	g FS		7		S
Input Capacitance	$(V_{DS} = 25 \text{ V}. V_{GS} = 0 \text{ V}.$	C _{iss}		983.8		pF
Output Capacitance	f = 1.0 MHz)	Coss		107.4		pF
Reverse Transfer Capacitance		C _{rss}		6.24		pF
Turn-On Delay Time	$(V_{DD} = 250 \text{ V}, I_D = 9 \text{ A},$	$t_{d(on)}$		19.7		ns
Rise Time	$(V_{DD} = 250 \text{ V}, I_D = 9 \text{ A},$ $R_D = 17 \text{ .}$	t _r		27.2		ns
Turn-Off Delay Time	$R_G = 6.2$)*	$t_{d(off)}$		37.6		ns
Fall Time	$R_G = 0.2$	t _f		22.7		ns
Total Gate Charge	(\(\) = 400 \(\) \(\) = 0 \(\)	Q_g		22.4		nC
Gate-Source Charge	$(V_{DS} = 400 \text{ V}, I_D = 9 \text{ A}, V_{GS} = 10 \text{ V})^*$	Q_gs		5.17		nC
Gate-Drain Charge		Q_{gd}		9.86		nC
SOURCE-DRAIN DIODE CHAR	ACTERISTICS					
Forward On-Voltage(1)	$(I_S = 9 \text{ A, V}_{GS} = 0 \text{ V,} \\ d_{1S}/d_t = 100\text{A/}\mu\text{s})$	V_{SD}			1.5	V
Forward Turn-On Time		t _{on}		**		ns
Reverse Recovery Time		t _{rr}		325.3		ns

^{*} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%

^{**} Negligible, Dominated by circuit inductance



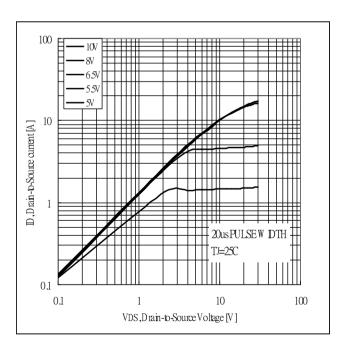
TYPICAL ELECTRICAL CHARACTERISTICS



12 (parties to 1) (parties to 25 to 25 to 75 to 100 to 125 to 150) TJ, Junction Temperature (C)

Fig 1. On-Resistance Variation with vs. Temperature

Fig.2 Breakdown Voltage Variation vs. Temperature



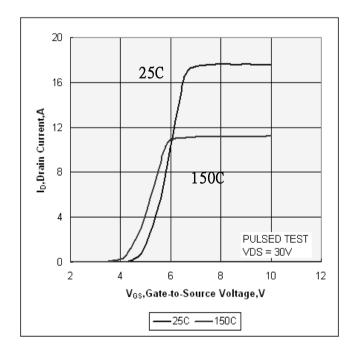


Fig 3. Typical Output Characteristics

Fig 4. Typical Transfer Characteristics





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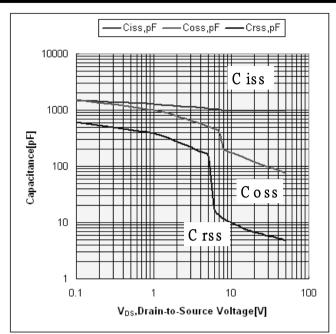


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

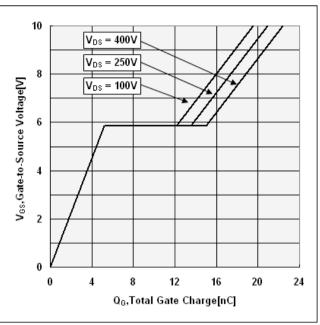


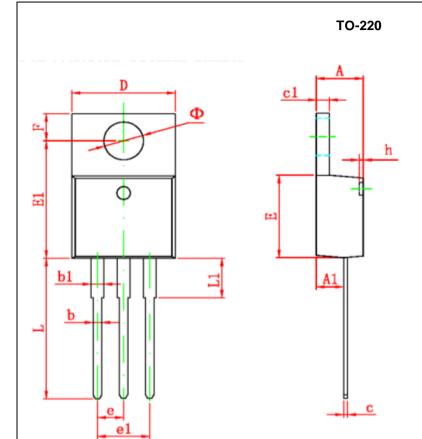
Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage





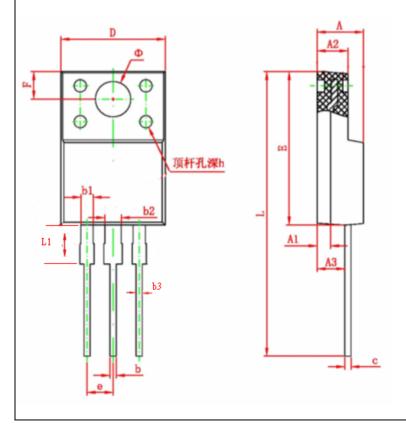
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PACKAGE DIMENSION



Crrmhol	Dimensions In Millimeters		
Symbol	Min.	Max	
Α	4.40	4.80	
A1	2.10	2.84	
ь	0.71	0.91	
b1	1.17	1.37	
С	0.30	0.60	
с1	1.17	1.47	
D	9.40	10.60	
E	8.40	9.60	
e	2.54 TYP.		
e1	4.90	5.60	
F	3.00 REF.		
Φ	3.50 REF.		
h	0.00	0.30	
L	12.50	14.00	
L1	3.50	4.00	

TO-220F



Crrookal	Dimensions In Millimeters		
Symbol	Min.	Max	
Α	3.80	4.70	
A1	1.3 REF.		
A2	2.20	3.20	
A3	2.10	3.20	
b	0.30	0.95	
b1	1.00	1.75	
Ъ2	1.00	1.75	
Ъ3	0.50	0.80	
С	0.30	0.90	
D	9.90	10.40	
E	14.60	16.20	
е	2.54 TYP.		
F	3.00 REF.		
Φ	3.50 REF.		
h	0.00	0.30	
L	28.00	30.00	
L1	3.20	3.55	





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IMPORTANT NOTICE

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